

	Type	L #	Hits	Search Text	DBs	Time Stamp
1	BRS	L14	1135	714/4.ccls.	USPAT	2006/06/13 14:26
2	BRS	L15	1571	714/4.ccls.	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	2006/06/13 14:27
3	BRS	L16	933	714/5.ccls.	US- PGPUB; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	2006/06/13 14:27

# Interference

	Type	L #	Hits	Search Text	DBs	Time Stamp
1	BRS	L2	377	716/6.ccls.	US-PGPUB	2006/06/13 12:51
2	BRS	L3	75	703/19.ccls.	US-PGPUB	2006/06/13 13:02
3	BRS	L4	5	(critical adj path) and (target adj device) and (electronic adj design)	US-PGPUB	2006/06/13 13:05
4	BRS	L5	79	(critical adj path) and (future same connect\$4)	US-PGPUB	2006/06/13 13:13
5	BRS	L6	0	(critical adj path) and (future adj delay\$2)	US-PGPUB	2006/06/13 13:13
6	BRS	L7	61	(critical adj path) and (future same delay\$2)	US-PGPUB	2006/06/13 13:13
7	BRS	L8	4	(critical adj path) and (future same delay\$2) and (target adj device)	US-PGPUB	2006/06/13 13:14
8	BRS	L9	24	(critical adj path) and (future same delay\$2) and (actual same delay\$2)	US-PGPUB	2006/06/13 13:18
9	BRS	L10	28	(critical adj path) and (statistic\$3 same element\$2)	US-PGPUB	2006/06/13 13:18

TS